

Notice of References Cited	Application/Control No. 10/623,570	Applicant(s)/Patent Under Reexamination KIM, JUNG-HOON	
	Examiner Hai L. Nguyen	Art Unit 2816	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,426,985	07-2002	Iwata et al.	375/371
*	B	US-5,642,069	06-1997	Waite, John C.	327/292
*	C	US-5,422,915	06-1995	Byers et al.	375/357
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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